


Search Notes 	Application/Control No. 10674334	Applicant(s)/Patent Under Reexamination LIU ET AL.
	Examiner Liu, Lin	Art Unit 2145

SEARCHED			
Class	Subclass	Date	Examiner
709	236	05/22/2007	L.L
370	225, 390	05/23/2007	L.L

SEARCH NOTES		
Search Notes	Date	Examiner
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	05/23/2007	L.L
Limited classified search of 709/236, 370/351, 400	05/23/2007	L.L
Consulted with examiner Bruckart, Benjamin for double patent rejection.	05/23/2007	L.L
709/236.ccls. and (@ad<20001214), 370/225, and 370/390.ccls. and @ad<20030930 reviewed consicely	05/23/2007	L.L
Diaglog search attached	05/23/2007	L.L

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner